## **Small Signal MOSFET**

# -20 V, -281 mA, Single P-Channel, SOT-883 (XDFN3) 1.0 x 0.6 x 0.4 mm Package

#### **Features**

- Single P-Channel MOSFET
- Ultra Low Profile SOT-883 (XDFN3) 1.0 x 0.6 x 0.4 mm for Extremely Thin Environments Such as Portable Electronics
- Low R<sub>DS(on)</sub> Solution in the Ultra Small 1.0 x 0.6 mm Package
- 1.5 V Gate Drive
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

#### **Applications**

- High Side Switch
- High Speed Interfacing
- Optimized for Power Management in Ultra Portable Solutions

#### **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise stated)

Parameter			Symbol	Value	Unit	
Drain-to-Source Voltage			V <sub>DSS</sub>	-20	V	
Gate-to-Source Voltage			V <sub>GS</sub>	±8	V	
Continuous Drain	Steady State	T <sub>A</sub> = 25°C	I <sub>D</sub>	-281	mA	
Current (Note 1)	State	T <sub>A</sub> = 85°C		-202		
	t ≤ 5 s	T <sub>A</sub> = 25°C		-332		
Power Dissipation (Note 1)	Steady State	T <sub>A</sub> = 25°C	$P_{D}$	155	mW	
	t ≤ 5 s			218		
Pulsed Drain Current	t <sub>p</sub> = 10 μs		I <sub>DM</sub>	-842	mA	
Operating Junction and Storage Temperature			$T_J$ , $T_{STG}$	–55 to 150	°C	
Source Current (Body Diode) (Note 2)			Is	-130	mA	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- Surface-mounted on FR4 board using the minimum recommended pad size, or 2 mm<sup>2</sup>, 1 oz Cu.
- 2. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%

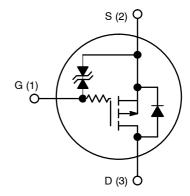


#### ON Semiconductor®

#### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> Max
	1.3 Ω @ -4.5 V	
22.17	2.0 Ω @ -2.5 V	_281 mA
–20 V	3.4 Ω @ -1.8 V	-281 IIIA
	4.5 Ω @ -1.5 V	

#### **P-CHANNEL MOSFET**



#### MARKING DIAGRAM



SOT-883 (XDFN3) CASE 506CB



65 = Specific Device Code M = Date Code

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTNS3A65PZT5G	SOT-883 (Pb-Free)	8000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

#### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	804	°C/W
Junction-to-Ambient - t ≤ 5 s (Note 3)	$R_{\theta JA}$	574	C/VV

<sup>3.</sup> Surface–mounted on FR4 board using the minimum recommended pad size, or 2 mm<sup>2</sup>, 1 oz Cu.

### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise stated)

Parameter	Symbol	Test Condition	n	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•						•
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = -2$	50 μΑ	-20			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>	I <sub>D</sub> = -250 μA, ref to	25°C		11		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 \text{ V},$ $V_{DS} = -20 \text{ V}$	T <sub>J</sub> = 25°C			-1	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> =	±5 V			±10	μΑ
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}$ , $I_D = -2$	250 μΑ	-0.4		-1.0	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				2.2		mV/°C
Drain-to-Source On Resistance		$V_{GS} = -4.5 \text{ V}, I_D = -200 \text{ mA}$			0.9	1.3	Ω
		$V_{GS} = -2.5 \text{ V}, I_D = -100 \text{ mA}$			1.3	2.0	
	R <sub>DS(on)</sub>	$V_{GS} = -1.8 \text{ V}, I_D = -50 \text{ mA}$			1.8	3.4	
		$V_{GS}$ = -1.5 V, $I_D$ = -10 mA			2.3	4.5	Ω
Forward Transconductance	9FS	$V_{DS} = -5 \text{ V}, I_D = -200 \text{ mA}$			0.58		S
Source-Drain Diode Voltage	$V_{SD}$	$V_{GS} = 0 \text{ V, } I_{S} = -100 \text{ mA}$			-0.8	-1.2	V
CHARGES & CAPACITANCES							
Input Capacitance	C <sub>ISS</sub>				44		
Output Capacitance	C <sub>OSS</sub>	$V_{GS} = 0 \text{ V, freq} = 1 \text{ MHz, } V_{DS} = -10 \text{ V}$			6.7		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>				5.5		
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = -4.5 \text{ V}, V_{DS} = -10 \text{ V};$ $I_D = -200 \text{ mA}$			1.1		
Threshold Gate Charge	Q <sub>G(TH)</sub>				0.1		nC
Gate-to-Source Charge	$Q_{GS}$				0.2		
Gate-to-Drain Charge	$Q_{GD}$				0.2		
SWITCHING CHARACTERISTICS, $V_{GS}$	= <b>4.5 V</b> (Note 4	1)					
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS} = -4.5 \text{ V}, V_{DD} = -10 \text{ V}, \\ I_D = -200 \text{ mA}, R_G = 2 \Omega$			18		
Rise Time	t <sub>r</sub>				32		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>				178		ns -
Fall Time	t <sub>f</sub>				84		

<sup>4.</sup> Switching characteristics are independent of operating junction temperatures

#### TYPICAL CHARACTERISTICS

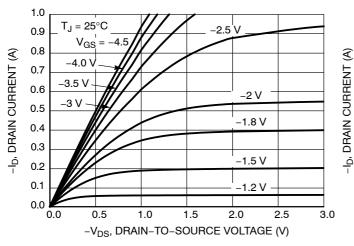


Figure 1. On-Region Characteristics

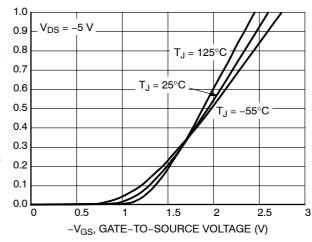


Figure 2. Transfer Characteristics

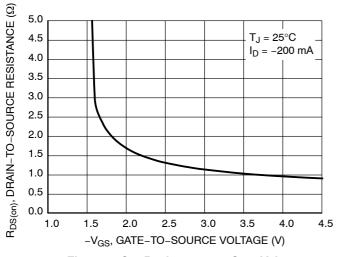


Figure 3. On-Resistance vs. Gate Voltage

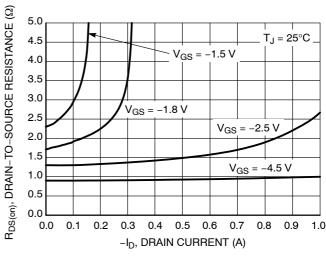


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

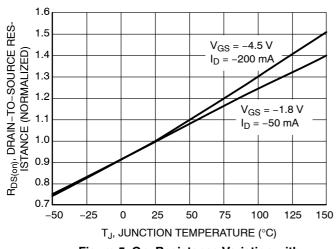


Figure 5. On–Resistance Variation with Temperature

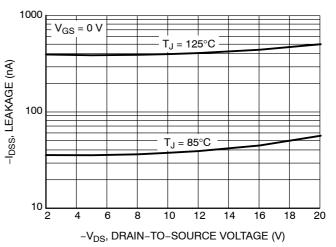
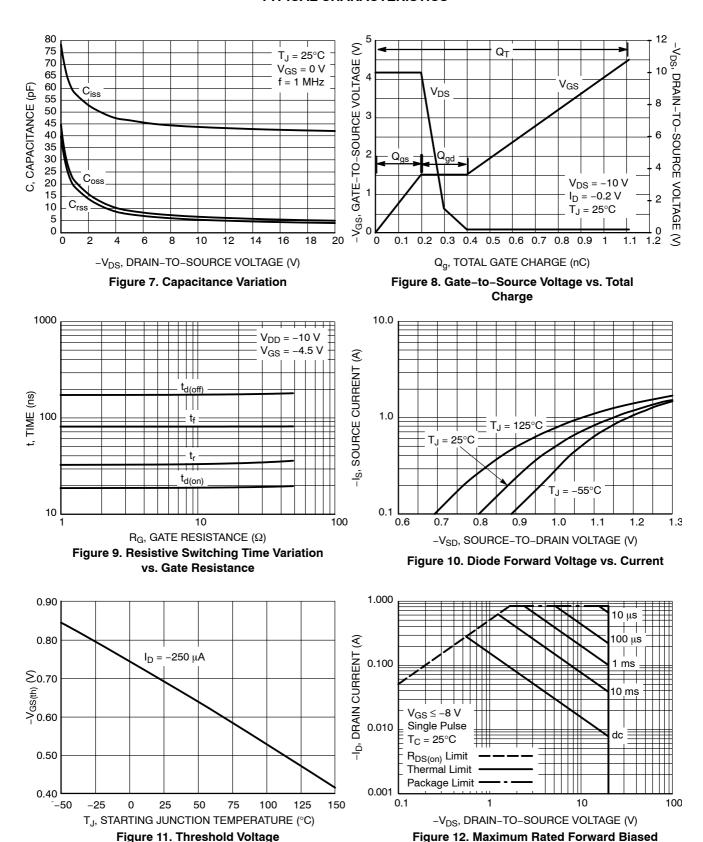


Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### TYPICAL CHARACTERISTICS



Safe Operating Area

#### **TYPICAL CHARACTERISTICS**

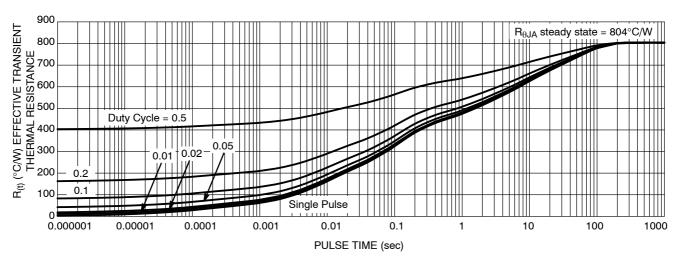
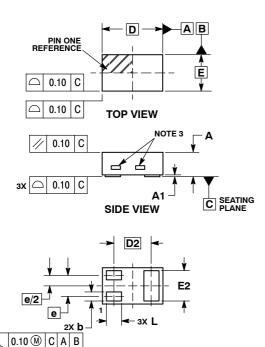


Figure 13. Thermal Response

#### PACKAGE DIMENSIONS

#### SOT-883 (XDFN3), 1.0x0.6, 0.35P CASE 506CB ISSUE A



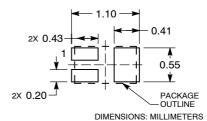
**BOTTOM VIEW** 

#### NOTES:

- DIMENSIONING AND TOLERANCING PER
   ASME V14 FM 1004
- ASME Y14.5M, 1994. 2. CONTROLLING DIMENSION: MILLIMETERS.
- EXPOSED COPPER ALLOWED AS SHOWN.

	MILLIMETERS		
DIM	MIN	MAX	
Α	0.340	0.440	
A1	0.000	0.030	
b	0.075	0.200	
D	0.950	1.075	
D2	0.620 BSC		
е	0.350 BSC		
Е	0.550	0.675	
E2	0.425	0.550	
L	0.170	0.300	

# RECOMMENDED SOLDER FOOTPRINT\*



\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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